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PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10080712	02/25/2002	321	005	2801	Shay

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3739

**CONTINUING DATA VERIFIED:

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** FOREIGN APPLICATIONS VERIFIED:

JAPAN 2001-55771 02/28/2001

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PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>
Foreign priority claimed 35 USC 119 conditions met Verified and Acknowledged Examiner's initials	<input type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> yes <input type="checkbox"/> no <i>dm</i>	ATTORNEY DOCKET NO 111856
TITLE : Method for assessing irradiation intensity of a laser beam, an apparatus for assessing irradiation intensity used under this method, and a laser beam irradiation system		
U.S. DEPT. OF COMM./PAT & TM-PTO-436L (Rev. 12-94)		

NOTICE OF ALLOWANCE MAILED		Assistant Examiner <i>David M. Shay</i> PRIMARY EXAMINER	CLAIMS ALLOWED	
			Total Claims 11	Print Claim for O.G 1
ISSUE FEE		DRAWING		
Amount Due	Date Paid	Sheets Drawn 89	Fig.s Drawn 8	Print Fig. 1
<input type="checkbox"/> TERMINAL DISCLAIMER		<i>7/12/04</i> Application Examiner		
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